



4N60

Power MOSFET

4 Amps, 600/650 Volts N-CHANNEL POWER MOSFET

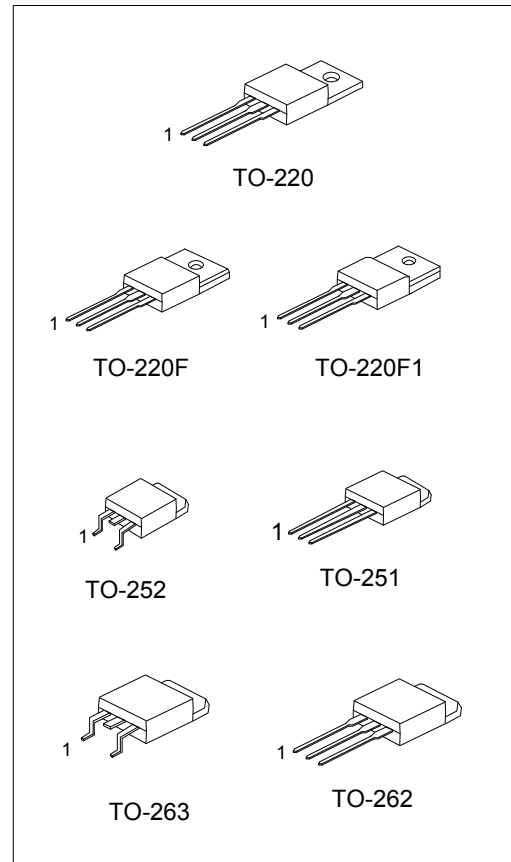
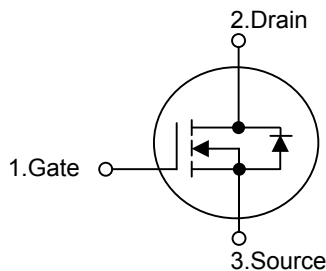
DESCRIPTION

The UTC **4N60** is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

FEATURES

- * $R_{DS(ON)} = 2.5\Omega @ V_{GS} = 10V$
- * Ultra Low Gate Charge (typical 15 nC)
- * Low Reverse Transfer CAPACITANCE (C_{RSS} = typical 8.0 pF)
- * Fast Switching Capability
- * Avalanche Energy Specified
- * Improved dv/dt Capability, high Ruggedness

SYMBOL



ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
4N60L-x-TA3-T	4N60G-x-TA3-T	TO-220	G	D	S	Tube
4N60L-x-TF1-T	4N60G-x-TF1-T	TO-220F1	G	D	S	Tube
4N60L-x-TF3-T	4N60G-x-TF3-T	TO-220F	G	D	S	Tube
4N60L-x-TM3-T	4N60G-x-TM3-T	TO-251	G	D	S	Tube
4N60L-x-TN3-R	4N60G-x-TN3-R	TO-252	G	D	S	Tape Reel
4N60L-x-T2Q-T	4N60G-x-T2Q-T	TO-262	G	D	S	Tube
4N60L-x-TQ3-R	4N60G-x-TQ3-R	TO-263	G	D	S	Tape Reel
4N60L-x-TQ3-T	4N60G-x-TQ3-T	TO-263	G	D	S	Tube

Note: Pin Assignment: G: Gate D: Drain S: Source

	(1) T: Tube, R: Tape Reel
	(2) TA3: TO-220, TF1: TO-220F1, TF3: TO-220F, TM3: TO-251 TN3: TO-252, T2Q: TO-262, TQ3: TO-263
	(3) A: 600V, B: 650V
	(4) G: Halogen Free, L: Lead Free

■ ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL		RATINGS	UNIT
Drain-Source Voltage	4N60-A	V_{DSS}		600	V
	4N60-B			650	V
Gate-Source Voltage		V_{GSS}		±30	V
Avalanche Current (Note 2)		I_{AR}		4.4	A
Drain Current	Continuous	I_D		4.0	A
	Pulsed (Note 2)	I_{DM}		16	A
Avalanche Energy	Single Pulsed (Note 3)	E_{AS}	4N60	260	mJ
			4N60-E	200	mJ
	Repetitive (Note 2)	E_{AR}		10.6	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt		4.5	V/ns
Power Dissipation	TO-220/TO-262/TO-263	P_D		106	W
	TO-220F/TO-220F1			36	W
	TO-251			50	W
	TO-252			50	W
Junction Temperature		T_J		+150	°C
Operating Temperature		T_{OPR}		-55 ~ +150	°C
Storage Temperature		T_{STG}		-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature

3. $L = 30\text{mH}$, $I_{AS} = 4\text{A}$, $V_{DD} = 50\text{V}$, $R_G = 25\ \Omega$, Starting $T_J = 25^\circ\text{C}$

4. $I_{SD} \leq 4.4\text{A}$, $di/dt \leq 200\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

■ THERMAL DATA

PARAMETER	PACKAGE	SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-262/TO-263	θ_{JA}	62.5	$^\circ\text{C}/\text{W}$
	TO-220F/TO-220F1		62.5	$^\circ\text{C}/\text{W}$
	TO-251		83	$^\circ\text{C}/\text{W}$
	TO-252		83	$^\circ\text{C}/\text{W}$
Junction to Case	TO-220/TO-262/TO-263	θ_{JC}	1.18	$^\circ\text{C}/\text{W}$
	TO-220F/TO-220F1		3.47	$^\circ\text{C}/\text{W}$
	TO-251		2.5	$^\circ\text{C}/\text{W}$
	TO-252		2.5	$^\circ\text{C}/\text{W}$

■ ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	4N60-A	BV_{DSS}	$V_{GS} = 0\text{ V}$, $I_D = 250\ \mu\text{A}$	600		V
	4N60-B			650		V
Drain-Source Leakage Current		I_{DSS}	$V_{DS} = 600\text{ V}$, $V_{GS} = 0\text{ V}$		10	μA
Gate-Source Leakage Current	Forward	I_{GSS}	$V_{GS} = 30\text{ V}$, $V_{DS} = 0\text{ V}$		100	nA
	Reverse		$V_{GS} = -30\text{ V}$, $V_{DS} = 0\text{ V}$		-100	nA
Breakdown Voltage Temperature Coefficient		$\Delta BV_{DSS}/\Delta T_J$	$I_D = 250\ \mu\text{A}$, Referenced to 25°C	0.6		$\text{V}/^\circ\text{C}$
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}$, $I_D = 250\ \mu\text{A}$	2.0		4.0	V
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS} = 10\text{ V}$, $I_D = 2.2\text{ A}$			2.5	Ω
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	$V_{DS} = 25\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{MHz}$		520	670	pF
Output Capacitance	C_{OSS}			70	90	pF
Reverse Transfer Capacitance	C_{RSS}			8	11	pF

■ ELECTRICAL CHARACTERISTICS(Cont.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{D(ON)}	V _{DD} = 300V, I _D = 4.0A, R _G = 25Ω (Note 1, 2)		13	35	ns
Turn-On Rise Time	t _R			45	100	ns
Turn-Off Delay Time	t _{D(OFF)}			25	60	ns
Turn-Off Fall Time	t _F			35	80	ns
Total Gate Charge	Q _G	V _{DS} = 480V,I _D = 4.0A, V _{GS} = 10 V (Note 1, 2)		15	20	nC
Gate-Source Charge	Q _{GS}			3.4		nC
Gate-Drain Charge	Q _{GD}			7.1		nC
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Drain-Source Diode Forward Voltage	V _{SD}	V _{GS} = 0 V, I _S = 4.4 A			1.4	V
Maximum Continuous Drain-Source Diode Forward Current	I _S				4.4	A
Maximum Pulsed Drain-Source Diode Forward Current	I _{SM}				17.6	A
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, I _S = 4.4 A,		250		ns
Reverse Recovery Charge	Q _{RR}	dl _F /dt = 100 A/μs (Note 1)		1.5		μC

Notes: 1. Pulse Test: Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$

2. Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

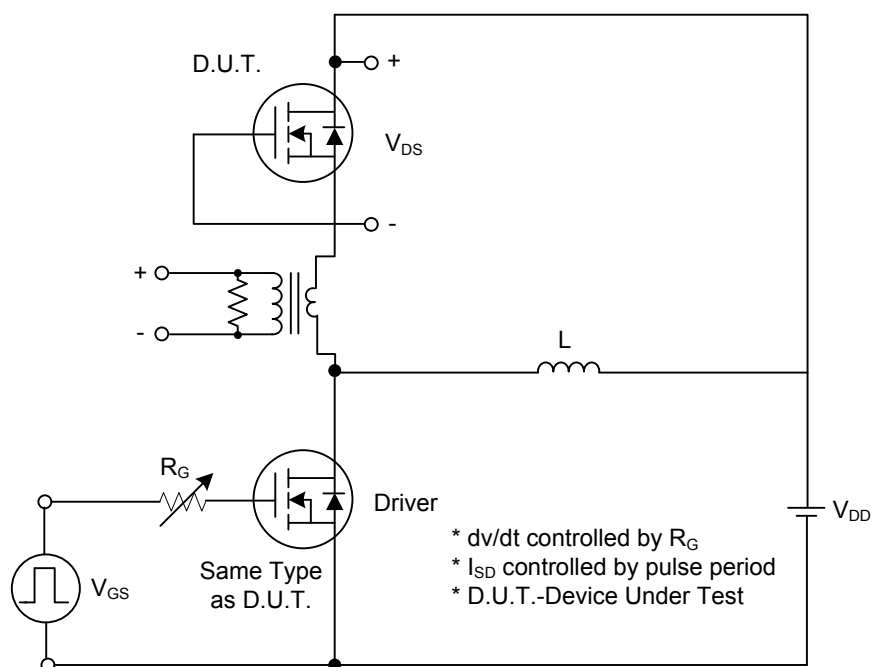


Fig. 1A Peak Diode Recovery dv/dt Test Circuit

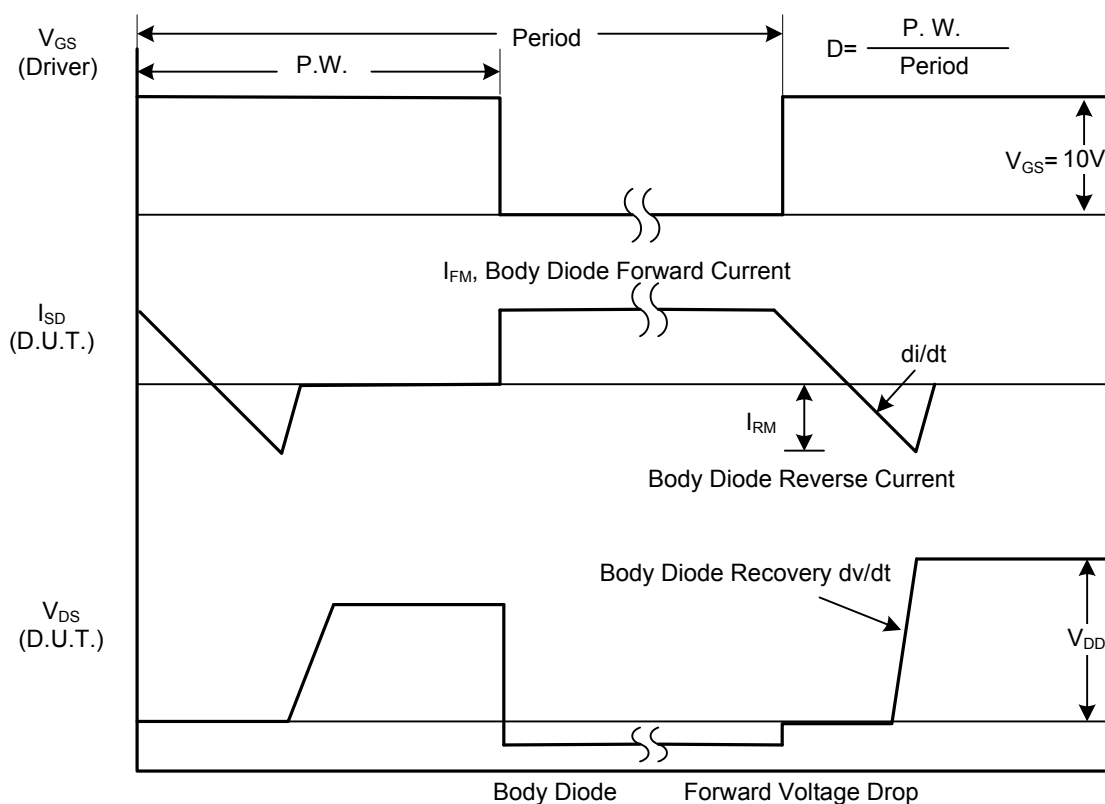


Fig. 1B Peak Diode Recovery dv/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS (Cont.)

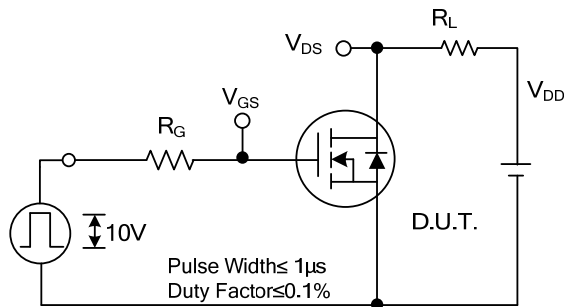


Fig. 2A Switching Test Circuit

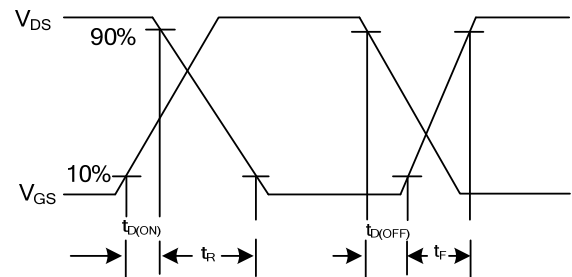


Fig. 2B Switching Waveforms

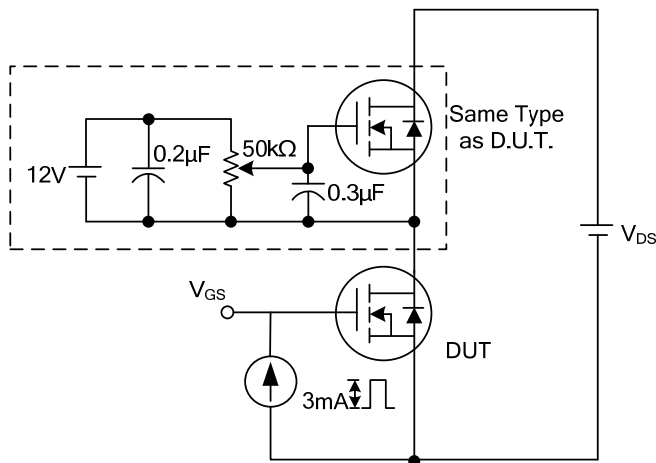


Fig. 3A Gate Charge Test Circuit

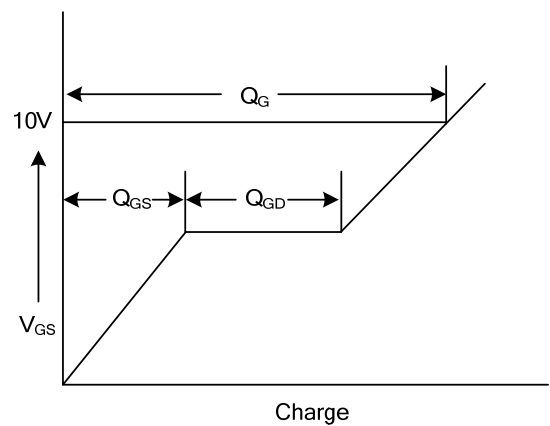


Fig. 3B Gate Charge Waveform

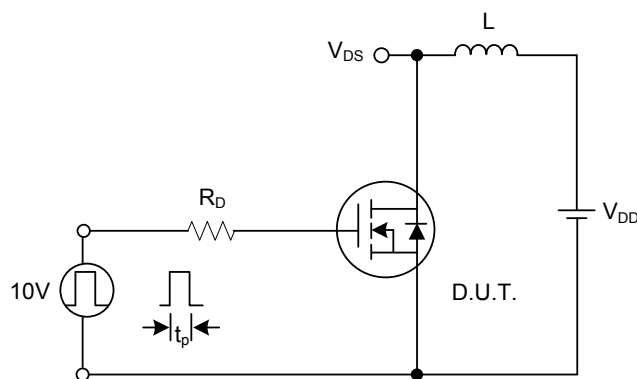


Fig. 4A Unclamped Inductive Switching Test Circuit

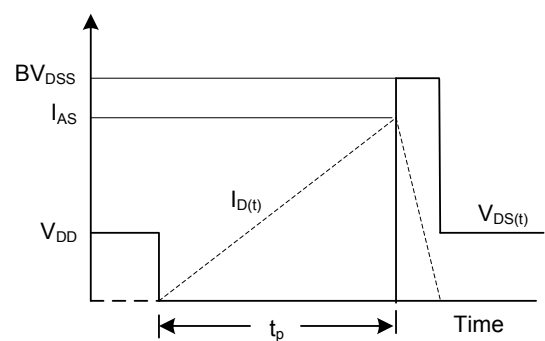
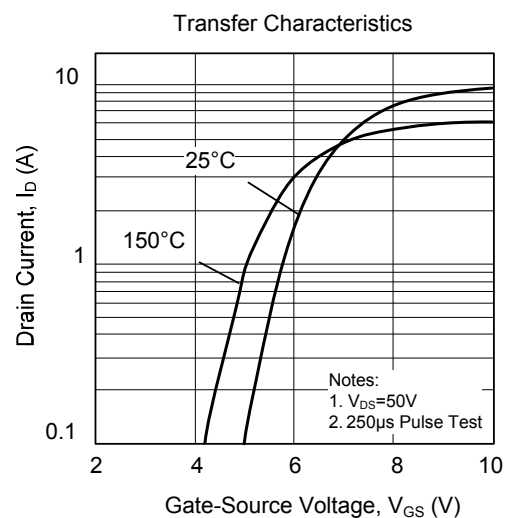
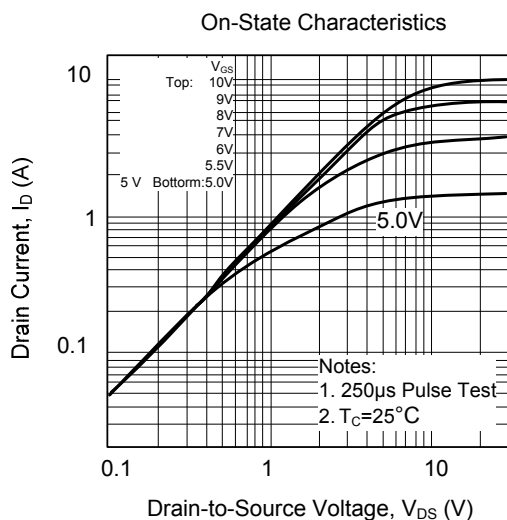
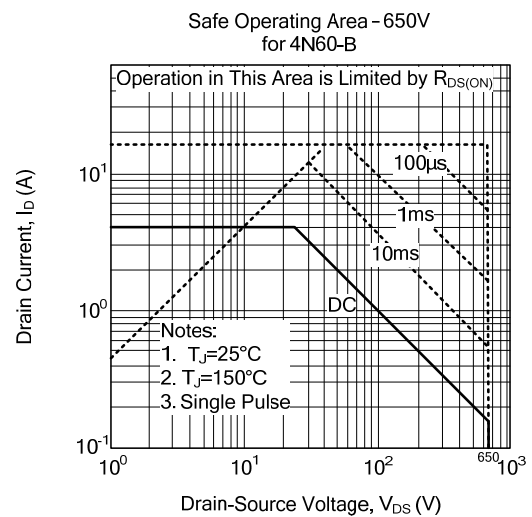
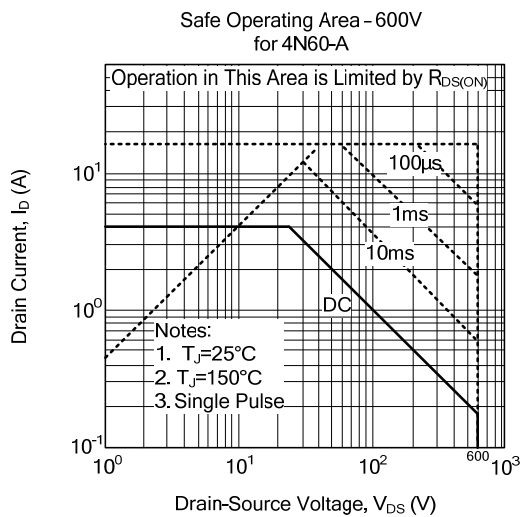
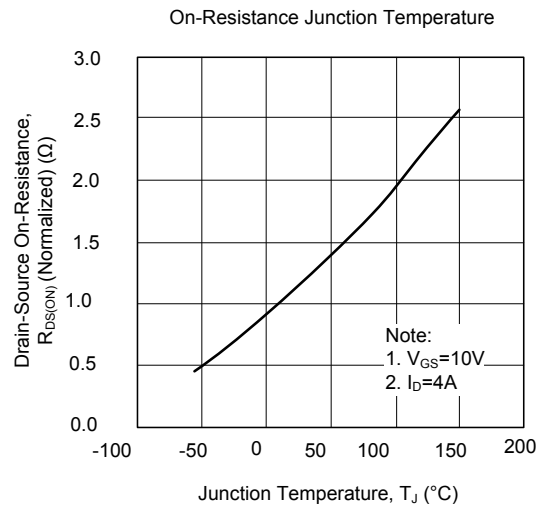
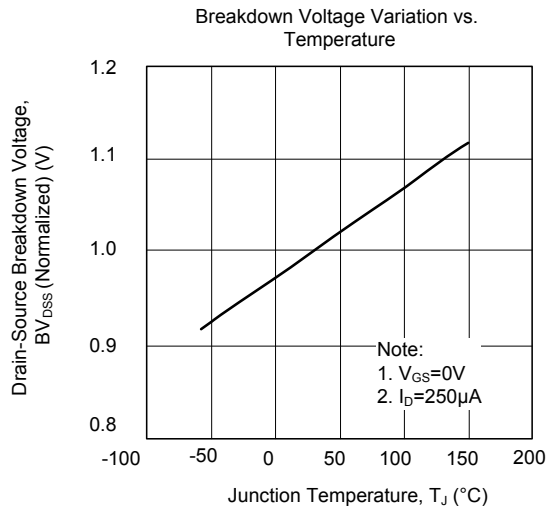


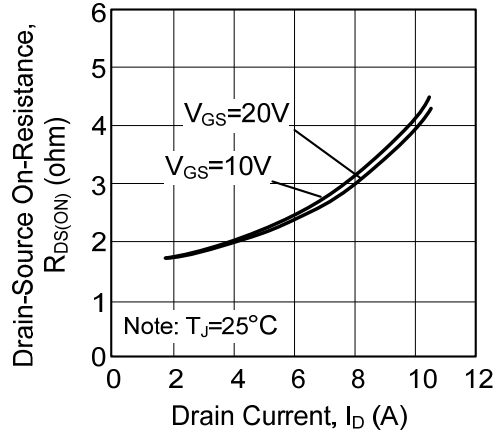
Fig. 4B Unclamped Inductive Switching Waveforms

TYPICAL CHARACTERISTICS

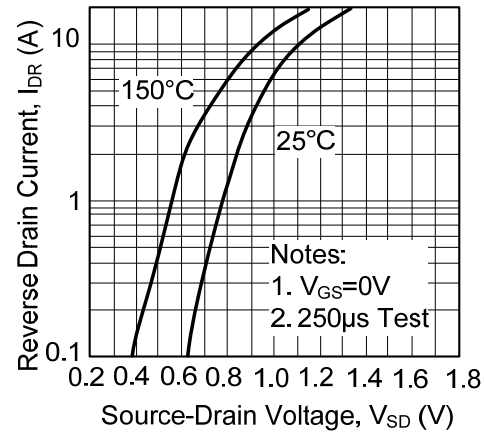


■ TYPICAL CHARACTERISTICS(Cont.)

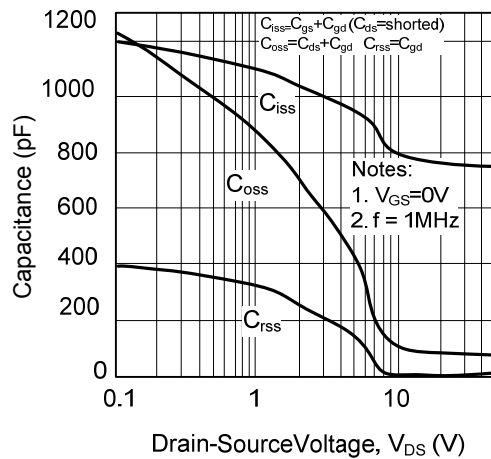
On-Resistance Variation vs. Drain Current and Gate Voltage



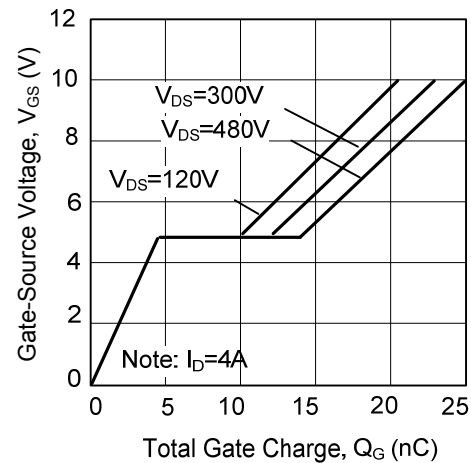
On State Current vs. Allowable Case Temperature



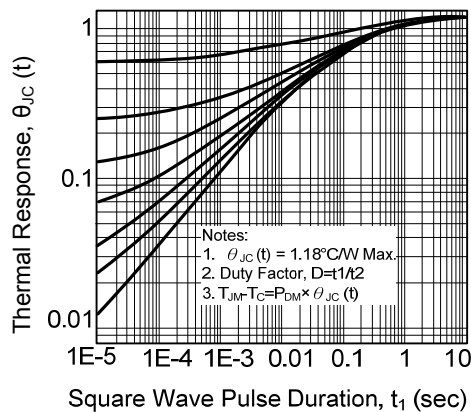
Capacitance Characteristics (Non-Repetitive)



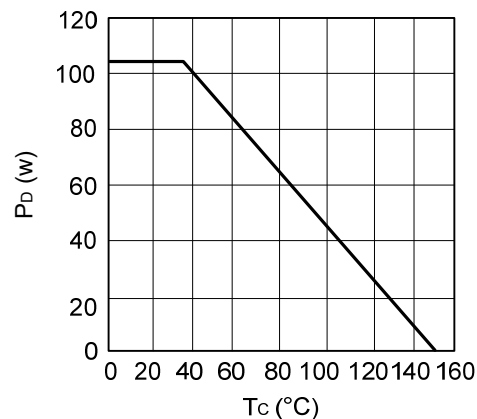
Gate Charge Characteristics



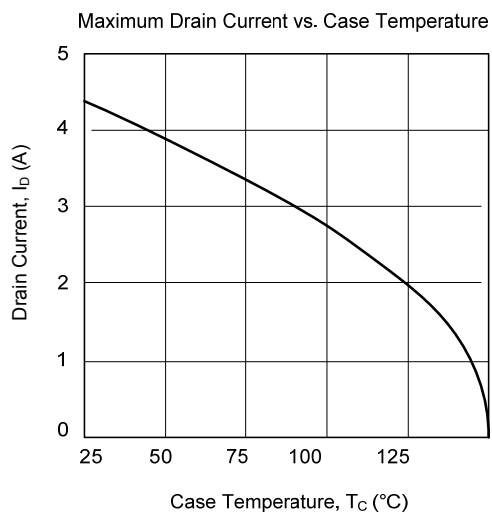
Transient Thermal Response Curve



Power Dissipation



■ TYPICAL CHARACTERISTICS(Cont.)



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